		Application/Control No.	Applicant	Applicant(s)/Patent under Reexamination
nssı	Issue Classification	10706429	SAFFRAN	SAFFRAN, MICHAEL D.
		Examiner	Art Unit	
		naney, Nichale L		
	ORIG	ORIGINAL	INTERNATIO	INTERNATIONAL CLASSIFICATION
	CLASS	SUBCLASS	CLAIMED	NON-CLAIMED
2		209	A 4 2 B 1 /	90 /
	CROSS REFERENCE(S)	ERENCE(S)		
SEVID	SUBCLASS (C	SUBCLASS (ONE SUBCLASS PER BLOCK)		
2	423			
381	71.6			

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(Date)

(Primary Examiner)

(Date)

(Legal Instruments Examiner)

(Assistant Examiner) Richale L. Haney

O.G. Print Figure က

O.G. Print Claim(s)

Total Claims Allowed: 5

GARY L. WELCH PRIMARY EXAMINER

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